


<b>Search Notes</b>  	<b>Application/Control No.</b>  10511456	<b>Applicant(s)/Patent Under Reexamination</b>  PAYNE, PATRICK
	<b>Examiner</b>  Kim, Edward J	<b>Art Unit</b>  2455

SEARCHED			
Class	Subclass	Date	Examiner
709	201-253		Edward J Kim
379	200-207		Edward J Kim
455	1-575.9		Edward J Kim

SEARCH NOTES		
Search Notes	Date	Examiner
Also searched the Derwent, JPO, EPO, and IBM databases		Edward J Kim
Also conducted inventor search on Patrick Payne		Edward J Kim
Updated East Search	10/18/2007	EJK
Discussed with SPE	10/18/2007	EJK
Updated search.	07/11/2008	EJK
Reviewed case according to the Amendment	05/01/2009	EJK
Reviewed case according to the amendment	08/28/2009	EJK
Reviewed case according to Amendment	06/02/2010	EJK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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